

ISO/IEC 17825:2016-01 (E)

Information technology - Security techniques - Testing methods for the mitigation of non-invasive attack classes against cryptographic modules

Contents		Page
Foreword		v
1	Scope	1
2	Normative references	1
3	Terms and definitions	1
4	Symbols and abbreviated terms	4
5	Document organization	4
6	Non-invasive attack methods	4
7	Associated Security Functions	7
8	Non-invasive Attack Test Methods	9
8.1	Introduction	9
8.2	Test Strategy	9
8.3	Side-Channel Analysis Workflow	9
8.3.1	Core Test Flow	9
8.3.2	Side-Channel Resistance Test Framework	10
8.3.3	Required Vendor Information	11
8.3.4	TA Leakage Analysis	12
8.3.5	SPA/SEMA Leakage Analysis	13
8.3.6	DPA/DEMA Leakage Analysis	14
9	Side-Channel Analysis of Symmetric-Key Cryptosystems	15
9.1	Introduction	15
9.2	Timing Attacks	15
9.3	SPA/SEMA	15
9.3.1	Attacks on Key Derivation Process	15
9.3.2	Collision Attacks	16
9.4	DPA/DEMA	16
9.4.1	Introduction	16
9.4.2	Test Vectors	18
9.4.3	Detailed Procedure	19
10	ASCA on Asymmetric Cryptography	25
10.1	Introduction	25
10.2	Detailed Side-Channel Resistance Test Framework	27
10.3	Timing Attacks	28
10.3.1	Introduction	28
10.3.2	Standard Timing Analysis	28
10.3.3	Micro-Architectural Timing Analysis	29
10.4	SPA/SEMA	29
10.4.1	Introduction	29
10.4.2	Standard SPA/SEMA	29
10.4.3	Markov SPA/SEMA	30
10.5	DPA/DEMA	30
10.5.1	Introduction	30

10.5.2	Standard DPA/DEMA	30
10.5.3	Address-Bit DPA/DEMA	32
11	Non-invasive attack mitigation pass/fail test metrics	33
11.1	Introduction	33
11.2	Security Level 3	34
11.2.1	Time Limit	34
11.2.2	SPA and SEMA	34
11.2.3	DPA and DEMA	34
11.2.4	Timing Analysis	34
11.2.5	Pre-processing conditions in differential analysis	34
11.2.6	Pass / Fail condition	34
11.3	Security Level 4	35
11.3.1	Time Limit	35
11.3.2	SPA and SEMA	35
11.3.3	DPA and DEMA	35
11.3.4	Timing Analysis	35
11.3.5	Pre-processing conditions in differential analysis	35
11.3.6	Pass / Fail condition	36
	Annex A (normative) Requirements for measurement apparatus	37
	Annex B (informative) Emerging attacks	38
	Annex C (informative) Quality criteria for measurement setups	40
	Annex D (informative) Chosen-input method to accelerate leakage analysis	42
	Bibliography	43